Silicon N-channel IGBT

1. FEATURES

- * High speed, low loss IGBT module.
- * Low thermal impedance due to direct liquid cooling.
- * High reliability, high durability module.

2. ABSOLUTE MAXIMUM RATINGS (Tc=25°C)

ltem		Symbol	Unit	Specification	
Collector Emitter Voltage		VCES	V	700	(4)
Gate Emitter Voltage		VGES	V	±20	
Collector Current	DC	C Ic	•	800	
	1m	s I _{Cp}		1600	
Forward Current	DC			800	
Forward Current	1m	s I _{FM}		1600	
Maximum Junction Temperature		Tjmax	0°C	175	
Temperature under switching con- ditions		T _{jop}	°C	-40 ~ +150	
Storage Temperature		T _{stg}	°C	-40 ~ +125	
Isolation Voltage		Viso	VRMS	2,500 (AC 1 minute)	
Screw Torque	Terminals (M6)	-		6.0	(1)
	Mounting (M5)	-	N∙m	4.0	(2)
	PCB Mounting (N	13) -		0.8	(3)

Notes: Recommended Value (1)5.5±0.5N·m, (2)3.5±0.5N·m, (3)0.65±0.15N·m.

(4)Please refer to figure of V_{CES} vs. Tc on the page of 6.

3. ELECTRICAL CHARACTERISTICS

Item		Symbol	Unit	Min.	Тур.	Max.	Test Conditions	
Collector Emitter Cut-Off Current		I CES	mA	-	-	1.0	Vce=700V, Vge=0V, Tj=25°C	
Gate Emitter Leakage Current		I _{GES}	nA	-	-	± 500	Vge=±20V, Vce=0V, Tj=25°C	
Collector Emitter Saturation Voltage		V _{CE(sat)}	V	-	1.55	2.0	Ic=800A, Vge=15V, Tj=25°C	
				-	1.80	-	Ic=800A, Vge=15V, Tj=150°C	
Gate Emitter Threshold Voltage		V _{GE(TO)}	V	6.0	6.7	7.5	Vce=5V, Ic=800mA, Tj=25°C	
Input Capacitance		Cies	nF	-	70	-	Vce=10V, Vge=0V, f=100kHz, Tj=25°C	
Switching Times	Rise Time	tr	μs	-	0.2	0.5	Vcc=300V, Ic=800A	
	Turn On Time	t _{on}		-	0.6	1.1	Ls=30nH , Rg(ext)=4.7 Ω , Cge=56nF	
	Fall Time	t _f		-	0.3	1.15	Vge=+15V/0V, Tj=150°C	
	Turn Off Time	t _{off}		-	1.3	2.2	Inductive load	
Peak Forward Voltage Drop		VF	V	-	1.35	1.7	If=800A, V _{GE} =0V, Tj=25°C	
				-	1.35	-	If=800A, V _{GE} =0V, Tj=150°C	
Reverse Recovery Time		trr	μs	-	0.4	0.85	Vcc=300V, Ic=800A,	
Turn On Loss		Eon(full)	mJ/P	-	20	50	Ls=30nH , Rg(ext)=4.7 Ω , Cge=56nF	
Turn Off Loss		E _{off(full)}	mJ/P	-	66	95	Vge=+15V/0V, Tj=150°C	
Reverse Recovery Loss		E _{rr(full)}	mJ/P	-	22	42	Inductive load	
Thermistor Resistance		R	kΩ	-	5	-	Tc=25 °C	
				-	0.16	-	Tc=150 °C	
Leakage Current between Thermistor and Other Terminals			mA	-	-	0.1	V=600Vp	
Thermal Resistance	IGBT	Rth(j-w)	K/W	-	-	0.135	Junction to water/fin, 10l/min, 50%LLC (per 1 arm)	
	FWD	Rth(j-w)	K/W	-	-	0.165		

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

* For actual application, please confirm this spec sheet is the newest revision.



4. PACKAGE OUTLINE DRAWING





5. CIRCUIT DIAGRAM



Thermistor T1, T2 and T3 are located on the same ceramic substrate with the IGBT and diode chips of phase U, V and W, respectively.

Note: This temperature measurement is not suitable for the short circuit or short term overload detection and should be used only for the module protection against long term overload or malfunction of the cooling system.

6. DEFINITION OF THE SYMBOLS





6in1 IGBT Module

MBB800TV7A

7. STATIC CHARACTERISTICS





Forward Current vs. Forward Voltage

Gate to Emitter Voltage vs. Gate Charge



8. DYNAMIC CHARACTERISTICS



Switching Time vs. Gate Resistance

Switching Loss vs. Gate Resistance



6in1 IGBT Module

MBB800TV7A



Transient Thermal Impedance Characteristics

VCES vs. Tc



9. THERMISTOR



Resistance vs. Temperature



10. PRECAUTIONS

10-1. Storage and Shipping Precautions

Important Notices

- (1) IGBT modules should always be stored under the following conditions.
 - •Temperature : 40 degrees Celsius, maximum.
 - $\bullet Humidity: 60\%~Relative Humidity, maximum.$
 - •Dust : Avoid storing the module in locations subject to dust.
 - •Harmful substances : The installation location should be free of corrosive gases such as sulfur dioxide and chlorine gas.
- •Other : Do not remove the conductive sponges or tapes attached to the signal gate and emitter gate. (2) Shipping Method
 - •To prevent the case cracking and/or the electrode bending, appropriate consideration should be given to properly insulate the shipping container from mechanical shock or sever vibration situation.
 - •Do not throw or drop the case while shipping. Treat them with care. The devices may break if they are not handled with care. Please do not use the IGBT modules that were dropped or damaged.
 - •Appropriate labeling on the outside of the shipping container should always be present.
 - •The shipping container itself should always be properly protected from both rain and water.

10-2. Precautions against Electrostatic Failure

Important Notices

Because the IGBT has a MOS gate structure and temperature sensing diode, you should always take the following precautions as measures to avoid generating static electricity.

- •Before starting operation, <u>do not remove the conductive sponge mounted between terminals of gate, emitter,</u> <u>collector, temperature sensing anode and cathode.</u>
- •When handling the IGBT module, ground our body via a high-value resistor (between $100k\Omega$ and $1M\Omega$), hold the package body, and <u>do not touch the terminals of gate, temperature sensing anode and cathode.</u>
- •Be sure to ground any parts which the IGBT module may touch, such as the work table or soldering iron.
- •Before testing or inspection, <u>be sure to check that any residual electric charge in measuring instruments has</u> <u>been removed</u>. Apply voltage to each terminal starting at 0V and return to 0V when finishing.



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